


<b>Searched</b>  	Application/Control No.  10525922	Applicant(s)/Patent Under Reexamination  LEE ET AL.
	Examiner Mehrpour, Naghmeh	Art Unit 2617

Class	SubClass	Date	Examiner
379	207.2	6/25/06	NM
	207.16		
	219		
	220.01		
	229		
	230		
	251		
	252		
	257		
455	401		
	567		
	414.1		

U.S. Patent and Trademark Office	Part of Paper No.: 6/25/06
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updated


3/22/07 NM

Interferer search  
was done in eDAN

3/22/07 NM

Interference search

3/22/07 NM

<b>Search Notes</b>  	Application/Control No.  10525922	Applicant(s)/Patent Under Reexamination  LEE ET AL.
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Notes	Date	Examiner
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Interference search  
is attached

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